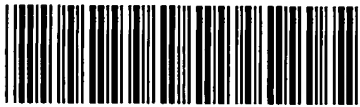


<b>Search Notes</b>  	<b>Application/Control No.</b>  10800105	<b>Applicant(s)/Patent Under Reexamination</b>  KUROIWA, TAKESHI
	<b>Examiner</b>  TRAN, MY-CHAU T	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	156, 169	01/09/2007	MCT
UPDATED	UPDATED	06/22/2007	MCT

SEARCH NOTES		
Search Notes	Date	Examiner
PALM Inventor; WEST - see printout	01/09/2007	MCT
UPDATED - see printout	06/22/2007	MCT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner